

**Search Notes**

Application/Control No.

10/823,653

Examiner

Jeffrey D. Lane

Applicant(s)/Patent under  
Reexamination

CHOI ET AL.

Art Unit

2828

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Semi-conductor laser with a mesa and a rounded corner	3/29/2006	JL
Pressure distribution ridges	3/29/2006	JL